

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination	
		10/763,868	EYTCHISON ET AL.	
Examiner		Art Unit		Page 1 of 1
Joiya M. Cloud		2444		

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0013852 A1	01-2002	Janik, Craig	709/231
*	B	US-2002/0073172 A1	06-2002	Armstrong et al.	709/219
*	C	US-2003/0093488 A1	05-2003	Yoshida et al.	709/213
*	D	US-2004/0039834 A1	02-2004	Saunders et al.	709/231
*	E	US-2005/0066063 A1	03-2005	Grigorovitch et al.	710/001
*	F	US-2005/0108754 A1	05-2005	Carhart et al.	725/047
*	G	US-2005/0267948 A1	12-2005	McKinley et al.	709/217
*	H	US-2006/0155400 A1	07-2006	Loomis, Stephen	700/094
*	I	US-7,136,934 B2	11-2006	Carter et al.	709/248
J	US-				
K	US-				
L	US-				
M	US-				

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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